

**Notice of References Cited**

Application/Control No.

10/589,511

Applicant(s)/Patent Under  
Reexamination  
OZAKI ET AL.

Examiner

Duy-Vu N. Deo

Art Unit

1713

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*	B	US-6,872,323	03-2005	Entley et al.	216/67
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**NON-PATENT DOCUMENTS**

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